

Search Notes

Application/Control No.

10/527,757

Examiner

Tsz K. Chiu

Applicant(s)/Patent under
Reexamination

SCHOTT ET AL.

Art Unit

2822

SEARCHED

Class	Subclass	Date	Examiner
257	421	12/21/2007	TC
257	427	12/21/2007	TC
257	515	12/21/2007	TC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (text search see attach)	12/21/2007	TC